

U.S. Patent Documents

Examiner						Sub-
Initial	No.	Patent No.	Date	Patentee	Class	class
AM	Α	4,217,977	8/1980	Tam		
	В	4,313,266	2/1982	Tam		
	С	5,924,154	7/1999	Gockel et al.		
AM	D	6,021,791	2/2000	Dryer et al.	M. "	19
	E				GA TOP	,C ^v
	F				70.	6 1/1-
	G					70, 1
	Н			·	7	
	I					00
	J					0
	K					

Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
MM	L	WO 99/04416	1/1999	WIPO				X
	М							
	N							
	0							
	P							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication				
	R					
	S					
	T					
Examiner	H	MARKOFF	Date Considered	8/18/03		

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.